

N-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	I _D (A) ^a	Q _g (Typ.)			
30	0.0085 at V _{GS} = 10 V	19.3	15 nC			
	0.0105 at V _{GS} = 4.5 V	17.3	13110			

SO-8 D D S D D Top View

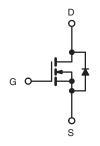
FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFET
- 100 % R_g Tested
- 100 % UIS Tested
- Compliant to RoHS Directive 2002/95/EC

HALOGEN **FREE**

APPLICATIONS

- Notebook DC/DC
 - High Side



N-Channel MOSFET

Ordering Information: Si4048DY-T1-GE3 (Lead (Pb)-free and Halogen-free)

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V_{DS}	30	V	
Gate-Source Voltage		V_{GS}	± 20	V
	T _C = 25 °C		19.3	
Continuous Drain Current (T. – 150 °C)	T _C = 70 °C		15.3	
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	l _D	12.7 ^{b, c}	A
	T _A = 70 °C		10.2 ^{b, c}	A
Pulsed Drain Current (300 μs)		I _{DM}	70	
Avalanche Current		I _{AS}	20	
Avalanche Energy	L = 0.1 mH	E _{AS}	20	mJ
Continuous Source-Drain Diode Current	T _C = 25 °C		5.1	Λ.
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	2.2 ^{b, c}	A
	T _C = 25 °C		5.7	
Maximum Dawar Dissination	ximum Power Dissipation $ T_{C} = 70 ^{\circ}\text{C} $ $ T_{A} = 25 ^{\circ}\text{C} $		3.6	W
waximum rowei Dissipation		P _D	2.5 ^{b, c}	VV
	T _A = 70 °C		1.6 ^{b, c}	
Operating Junction and Storage Temperatur	T _J , T _{sta}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS							
Parameter	Symbol	Typical	Maximum	Unit			
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	39	50	°C/W		
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	18	22			

Notes:

- a. Based on T_C = 25 °C.
 b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Maximum under steady state conditions is 85 °C/W.



SPECIFICATIONS (T _J = 25 °C Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static				.,,,,	1114211		
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$			33		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 6.3			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_{D} = 250 \mu A$	1		3	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
		V _{DS} = 30 V, V _{GS} = 0 V			1	<u> </u>	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V, T _J = 55 °C			5	μΑ	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α	
	Б	V _{GS} = 10 V, I _D = 15 A		0.0070	0.0085		
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 10 \text{ A}$		0.0085	0.0105	5 Ω	
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 15 A		78		S	
Dynamic ^b					•	L	
Input Capacitance	C _{iss}			2060			
Output Capacitance	C _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		335		pF	
Reverse Transfer Capacitance	C _{rss}			132			
		V _{DS} = 15 V, V _{GS} = 10 V, I _D = 10 A		34	51	51 23 nC	
Total Gate Charge	Gate Charge Q _g			15	23		
Gate-Source Charge	Q_{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$		6.5			
Gate-Drain Charge	Q_{gd}			4.0			
Gate Resistance	R_g	f = 1 MHz	0.15	0.65	1.3	Ω	
Turn-On Delay Time	t _{d(on)}			19	35		
Rise Time	t _r	V_{DD} = 15 V, R_L = 15 Ω		11	22		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		18	35		
Fall Time	t _f			8	16	ns	
Turn-On Delay Time	t _{d(on)}			10	20	113	
Rise Time	t _r	V_{DD} = 15 V, R_L = 15 Ω		9	18		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		21	40		
Fall Time	t _f			8	16		
Drain-Source Body Diode Characteristi	cs				1		
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			5.1	Α	
Pulse Diode Forward Current	I _{SM}				70	, ,	
Body Diode Voltage	V_{SD}	$I_S = 4.0 \text{ A}, V_{GS} = 0 \text{ V}$		0.76	1.1	V	
Body Diode Reverse Recovery Time	t _{rr}			23	45	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 5.0 A, dl/dt = 100 A/μs, T _{.1} = 25 °C		13	25	nC	
Reverse Recovery Fall Time	t _a	.μ 5.57, απαι – 1007νμο, 1η – 20		12		ne	
Reverse Recovery Rise Time	t _b			11		ns	

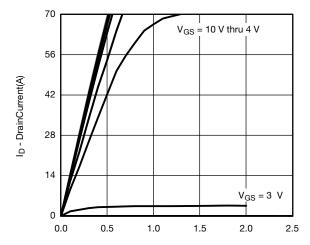
- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



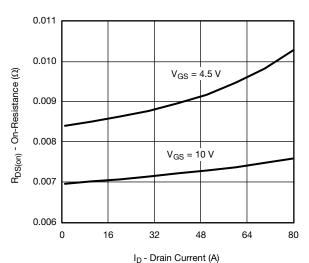


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

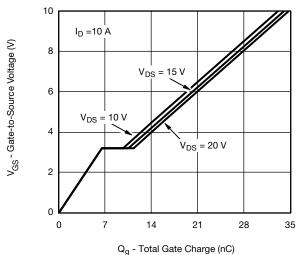


V_{DS} - Drain-to-Source Voltage (V)

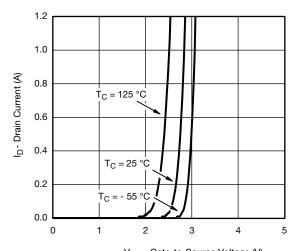
Output Characteristics



On-Resistance vs. Drain Current and Gate Voltage

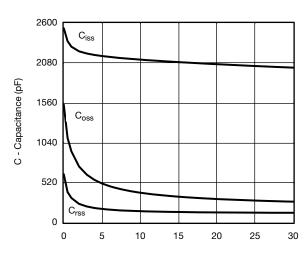


Gate Charge (nc)



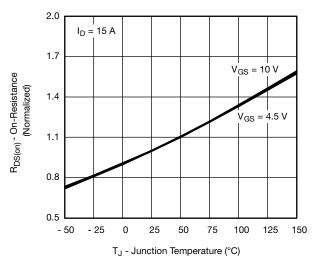
V_{GS} - Gate-to-Source Voltage (V)

Transfer Characteristics



V_{DS} - Drain-to-Source Voltage (V)

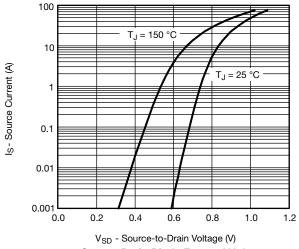
Capacitance



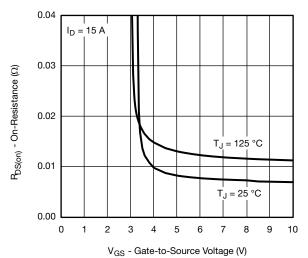
On-Resistance vs. Junction Temperature

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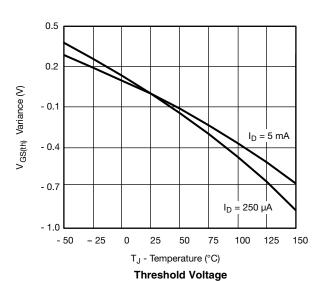
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

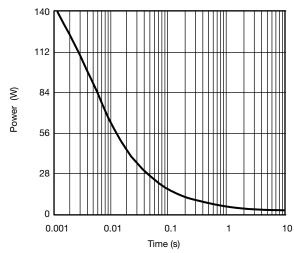


Source-Drain Diode Forward Voltage

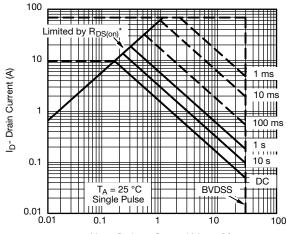


On-Resistance vs. Gate-to-Source Voltage





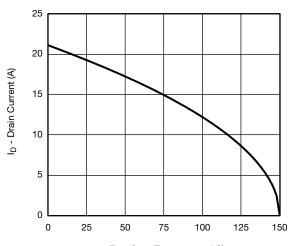
Single Pulse Power (Junction-to-Ambient)



 $\rm V_{DS}$ - Drain-to-Source Voltage (V) * V $_{GS}$ > minimum V $_{GS}$ at which $\rm R_{DS(on)}$ is specified

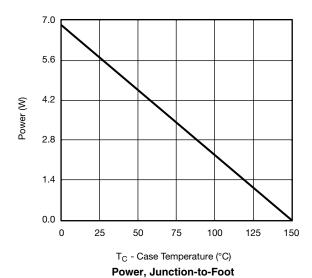
Safe Operating Area, Junction-to-Ambient

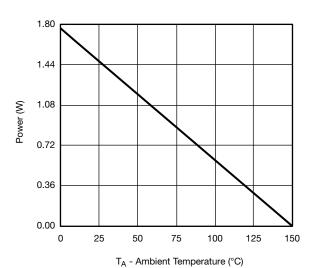
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



T_C - Case Temperature (°C)

Current Derating*



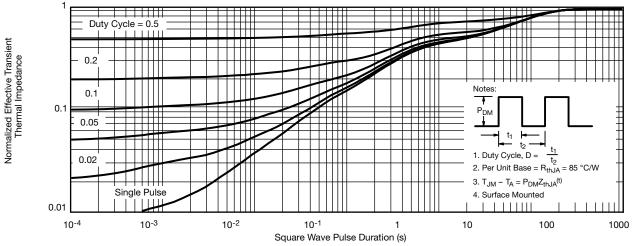


Power, Junction-to-Ambient

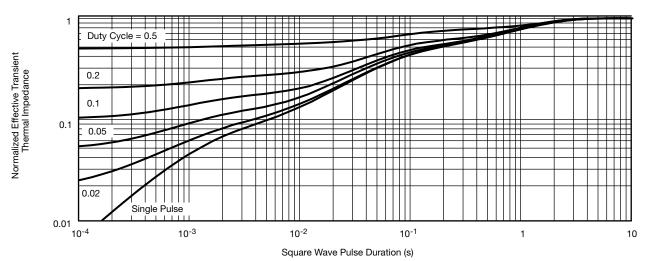
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

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SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







	MILLIM	IETERS	INC	INCHES		
DIM	Min	Max	Min	Max		
Α	1.35	1.75	0.053	0.069		
A ₁	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
E	3.80	4.00	0.150	0.157		
е	1.27	BSC	0.050	0.050 BSC		
Н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
FCN: C-06527-Bey 11-Sen-06						

ECN: C-06527-Rev. I, 11-Sep-06

DWG: 5498

Document Number: 71192 www.vishay.com 11-Sep-06 www.vishay.com



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)

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